

## TEST REPORT

Applicant	Hitachi Hi-Rel Power Electronics Pvt. Ltd.
Address	SM 3 & 4, Sanand – II GIDC, Industrial Estate, Boll Village, Sanand – 382 110, Gujarat, India.



Manufacturer or Supplier	Hitachi Hi-Rel Power Electronics Pvt. Ltd.
Address	SM 3 & 4, Sanand – II GIDC, Industrial Estate, Boll Village, Sanand – 382 110, Gujarat, India.
Product	Solar Inverter
Brand Name	<b>HITACHI</b>
Model	Hiverter Si-6K-H2, Hiverter Si-3K-H2
Additional Model & Model Difference	Hiverter Si-5K-H2, Hiverter Si-4.6K-H2, Hiverter Si-4K-H2, Hiverter Si-3.6K-H2; See items 2.1
Date of tests	Nov. 22, 2017 ~ Dec. 01, 2017



The submitted sample of the above equipment has been tested according to the requirements of the following standards:

- ☒ EN 61000-6-3:2007 + A1:2011+AC:2012
- ☒ EN 61000-3-2:2014
- ☒ EN 61000-3-3:2013
- ☒ EN 61000-3-11:2001
- ☒ EN 61000-3-12:2011
- ☒ EN 61000-6-2:2005

**CONCLUSION: The submitted sample was found to COMPLY with the test requirement**

Tested by Ryan Lu Project Engineer / EMC Department	Approved by Glyn He Assistant Manager / EMC Department
	 Date: Nov. 27, 2019

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## RELEASE CONTROL RECORD

ISSUE NO.	REASON FOR CHANGE	DATE ISSUED
CE170829N003	Original release	Dec. 08, 2017
CE191010N002	Based on the original report CE170829N003 changed the address of applicant/ manufacturer, model No. and brand name, but it doesn't need to be retested after engineer evaluated.	Nov. 27, 2019

## 1 SUMMARY OF TEST RESULTS

The EUT has been tested according to the following specifications:

EMISSION			
Standard	Test Type	Result	Remarks
EN61000-6-3:2007+ A1:2011+AC:2012	Conducted test	PASS	Meets Limits Minimum passing margin is -0.61dB at 0.40000MHz
	Radiated test (30MHz~1GHz)	PASS	Meets limits minimum passing margin is -3.65dB at 93.2925MHz
EN 61000-3-2:2014	Harmonic current emissions	PASS	Meets the requirements.
EN 61000-3-3:2013	Voltage fluctuations & flicker	PASS	Meets the requirements.
EN 61000-3-12:2011	Harmonic current emissions	PASS	Meets the requirements.
EN 61000-3-11:2001	Voltage fluctuations & flicker	PASS	Meets the requirements.

IMMUNITY (EN 61000-6-2:2005)			
Standard	Test Type	Result	Remarks
IEC 61000-4-2:2008 ED. 2.0	Electrostatic discharge immunity test	PASS	Electrostatic Discharge – ESD: 8kV Air discharge, 4kV Contact discharge, Performance Criterion A
IEC 61000-4-3:2010 ED. 3.2	Radiated, radio-frequency, electromagnetic field immunity test	PASS	Radio-Frequency Electromagnetic Field Susceptibility Test – RS: 80-1000 MHz, 10V/m, 80% AM (1kHz), 1400-2000 MHz, 3V/m, 80% AM (1kHz) 2000-2700 MHz, 1V/m, 80% AM (1kHz) Performance Criterion A
IEC 61000-4-4:2012 ED. 3.0	Electrical fast transient / burst immunity test.	PASS	Electrical Fast Transient/Burst - EFT AC Power line: 2kV, DC Power line 2kV, Performance Criterion A
IEC 61000-4-5:2017 ED. 3.1	Surge immunity test	PASS	Surge Immunity Test: 1.2/50 us Open Circuit Voltage, 8 /20 us Short Circuit Current, AC Power Line: line to line 1 kV, line to earth 2kV, DC Power Line: line to line 0.5kV Performance Criterion B
IEC 61000-4-6:2013 ED. 4.0	Immunity to conducted disturbances, induced by radio-frequency fields	PASS	Conducted Radio Frequency Disturbances Test – CS: 0.15-80 MHz, 10Vrms, 80% AM, 1kHz, Performance Criterion A
IEC 61000-4-8:2009 ED. 2.0	Power frequency magnetic field immunity test.	PASS	Power Frequency Magnetic Field Test, 50 Hz, 30A/m, Performance Criterion A

## 1.1 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of  $k=2$ .

MEASUREMENT	FREQUENCY	UNCERTAINTY
Mains Terminal Disturbance Voltage Test	0.15MHz ~ 30MHz	+ /-2.70 dB
Radiated Disturbance Test	30MHz ~ 1000MHz	+ /-4.03 dB

## 2 GENERAL INFORMATION

### 2.1 GENERAL DESCRIPTION OF EUT

<b>PRODUCT</b>	Solar Inverter
<b>MODEL NO.</b>	Hiverter Si-6K-H2, Hiverter Si-3K-H2
<b>ADDITIONAL MODELS</b>	Hiverter Si-5K-H2, Hiverter Si-4.6K-H2, Hiverter Si-4K-H2, Hiverter Si-3.6K-H2,
<b>POWER SUPPLY</b>	DC input 90-580V AC output 220-230V 50/60Hz
<b>THE HIGHEST OPERATING FREQUENCY</b>	Below 108MHz
<b>DATA CABLE SUPPLIED</b>	N/A

#### NOTE:

1. For the test results, the EUT had been tested with all conditions. But only the worst case was showed in test report.
2. For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.
3. Please refer to the EUT photo document (Reference No.: 191010N002) for detailed product photo.
4. Additional models Hiverter Si-5K-H2, Hiverter Si-4.6K-H2, Hiverter Si-4K-H2, Hiverter Si-3.6K-H2 are identical with the test model Hiverter Si-6K-H2 and Hiverter Si-3K-H2 except the model number and power rating for trading purpose. The difference has been considered during this test, full test was performed for the model Hiverter Si-6K-H2 and partial test for the model Hiverter Si-3K-H2 test CE, RE, Harmonics and flicker.



## 2.2 DESCRIPTION OF TEST MODES

The EUT was tested under the following modes' the final worst mode was marked in boldface and recorded in this report.

◆ For Conducted Emission Test

Description of Test Mode	Test Model	Test Voltage
Full load and Grid	Hiverter Si-6K-H2	<b>Input DC 300V, output AC 230V 50Hz</b>
		Input DC 410V, output AC 230V 50Hz
		Input DC 520V, output AC 230V 50Hz
	Hiverter Si-3K-H2	Input DC 160V, output AC 230V 50Hz Input DC 340V, output AC 230V 50Hz Input DC 520V, output AC 230V 50Hz

◆ For Radiated Emission Test

Description of Test Mode	Test Model	Test Voltage
Full load and Grid	Hiverter Si-6K-H2	<b>Input DC 300V, output AC 230V 50Hz</b>
		Input DC 410V, output AC 230V 50Hz
		Input DC 520V, output AC 230V 50Hz
	Hiverter Si-3K-H2	Input DC 160V, output AC 230V 50Hz Input DC 340V, output AC 230V 50Hz Input DC 520V, output AC 230V 50Hz

◆ For Harmonics and Flicker Tests

Description of Test Mode	Test Model	Test Voltage
Full load and Grid	Hiverter Si-6K-H2 Hiverter Si-3K-H2	<b>Input DC 520V, output AC 230V 50Hz</b>

◆ For Immunity Tests

Description of Test Mode	Test Voltage
10% load and Grid	<b>Input DC 520V, output AC 230V 50Hz</b>

## 2.3 GENERAL DESCRIPTION OF APPLIED STANDARDS

The EUT has been tested and complied with the requirements of the following standards:

**EN 61000-6-3:2007 + A1:2011+AC:2012**

**EN 61000-3-2:2014**

**EN 61000-3-3:2013**

**EN 61000-3-12:2011**

**EN 61000-3-11:2001**

**EN 61000-6-2:2005**

IEC 61000-4-2:2008 ED. 2.0

IEC 61000-4-3:2010 ED. 3.2

IEC 61000-4-4:2012 ED. 3.0

IEC 61000-4-5:2017 ED. 3.1

IEC 61000-4-6:2013 ED. 4.0

IEC 61000-4-8:2009 ED. 2.0

**Notes:** The above IEC basic standards are applied with latest version if customer has no special requirement.

## 2.4 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit without any other necessary accessory or support units.

### 3 EMISSION TEST

#### 3.1 CONDUCTED EMISSION MEASUREMENT

##### 3.1.1 LIMITS OF CONDUCTED EMISSION MEASUREMENT

FREQUENCY (MHz)	dBuV	
	Quasi-peak	Average
0.15 - 0.5	66 - 56	56 - 46
0.50 - 5.0	56	46
5.0 - 30.0	60	50

**Note:** (1) The lower limit shall apply at the transition frequencies.  
 (2) The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

##### 3.1.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EMI Test Receiver	Rohde&Schwarz	ESCS30	100340	May 04,17	May 03,18
Pulse Limiter	Rohde&Schwarz	ESH3-Z2	100168	Oct. 20,17	Oct. 19,18
Artificial Mains Network	Rohde&Schwarz	ESH2-Z5	100071	Apr. 05,17	Apr. 04,18
Voltage probe	SCHWARZBEC K	TK 9421	TK 9421-176	Jan. 04,17	Jan. 03,18
Test software	ADT	ADT_Cond_ V7.3.7	N/A	N/A	N/A

**NOTE:** 1. The test was performed in shielding Room 843.  
 2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA

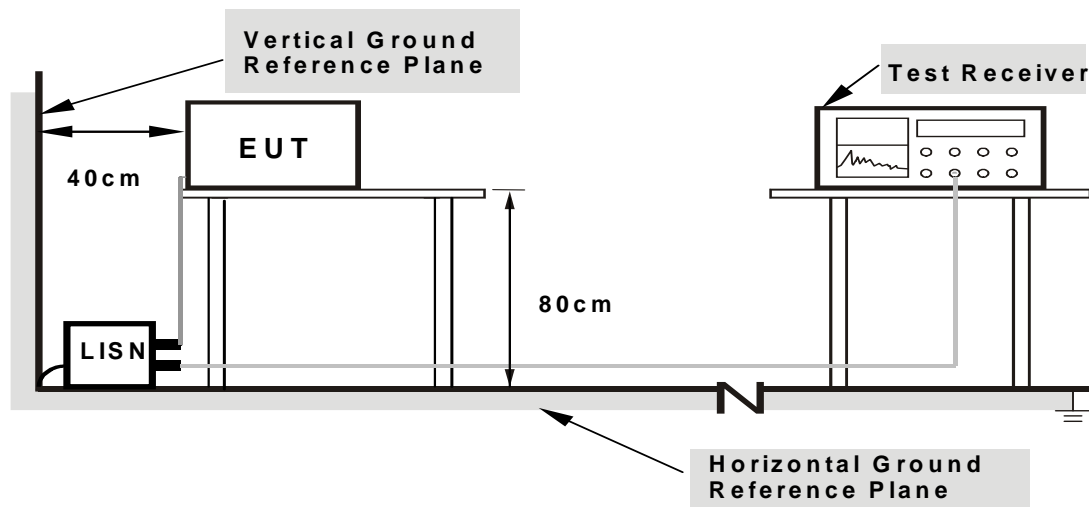
### 3.1.3 TEST PROCEDURE

- The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- The frequency range from 150 kHz to 30 MHz was searched. Emission levels under (Limit – 20dB) were not recorded.

### 3.1.4 DEVIATION FROM TEST STANDARD

No deviation

### 3.1.5 TEST SETUP



- Note:**
- 1.Support units were connected to second LISN.
  - 2.Both of LISNs (AMN) are 80cm from EUT and at least 80cm from other units and other metal planes support units.

### 3.1.6 EUT OPERATING CONDITIONS

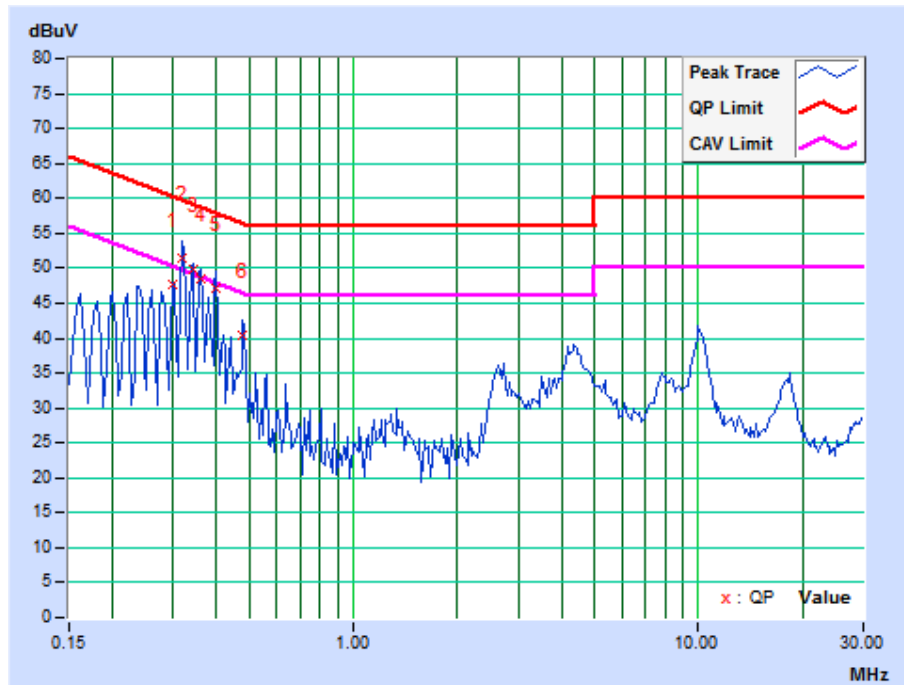
- Turned on the power of all equipment.
- EUT was operated according to the type description in manufacturer's specifications or the User's Manual.

### 3.1.7 TEST RESULTS

TEST MODE	Full load and Grid	6dB BANDWIDTH	9 kHz
TEST VOLTAGE	Input DC 300V, output AC 230V 50Hz	PHASE	Line (L)
ENVIRONMENTAL CONDITIONS	23 deg. C, 54% RH	TESTED BY: Walker	
TEST MODEL	Hiverter Si-6K-H2		

No	Freq. [MHz]	Corr. Factor (dB)	Reading Value		Emission Level		Limit		Margin	
			[dB (uV)]		[dB (uV)]		[dB (uV)]		(dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.29844	8.61	39.08	33.36	47.69	41.97	60.29	50.29	-12.59	-8.31
2	0.31797	8.63	42.71	38.96	51.34	47.59	59.76	49.76	-8.42	-2.17
3	0.34141	8.64	41.25	34.98	49.89	43.62	59.17	49.17	-9.27	-5.54
4	0.36094	8.67	39.92	33.26	48.59	41.93	58.71	48.71	-10.12	-6.78
5	0.40000	8.72	38.55	38.52	47.27	47.24	57.85	47.85	-10.58	-0.61
6	0.47813	8.66	31.61	30.06	40.27	38.72	56.37	46.37	-16.10	-7.65

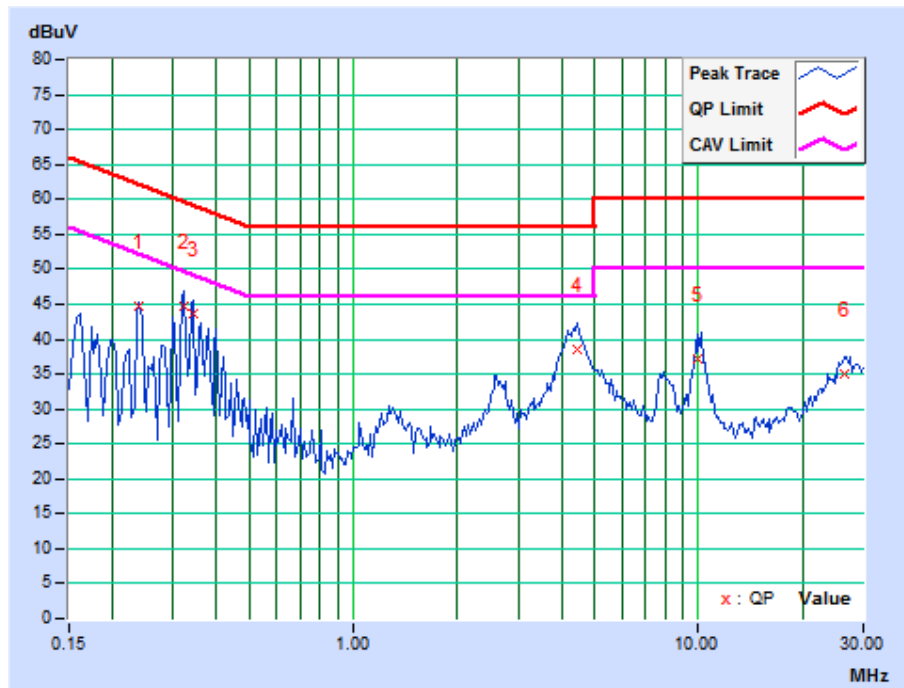
**REMARKS:** The emission levels of other frequencies were very low against the limit.



TEST MODE	Full load and Grid	6dB BANDWIDTH	9 kHz
TEST VOLTAGE	Input DC 300V, output AC 230V 50Hz	PHASE	Neutral (N)
ENVIRONMENTAL CONDITIONS	23 deg. C, 54% RH	TESTED BY: Walker	
TEST MODEL	Hiverter Si-6K-H2		

No	Freq. [MHz]	Corr. Factor (dB)	Reading Value		Emission Level		Limit		Margin	
			[dB (uV)]		[dB (uV)]		[dB (uV)]		(dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.23984	8.40	36.21	35.46	44.61	43.86	62.10	52.10	-17.49	-8.24
2	0.32188	8.60	36.08	34.06	44.68	42.66	59.66	49.66	-14.98	-7.00
3	0.34141	8.61	35.02	28.27	43.63	36.88	59.17	49.17	-15.54	-12.29
4	4.44141	9.29	29.12	23.96	38.41	33.25	56.00	46.00	-17.59	-12.75
5	9.91797	9.40	27.72	23.44	37.12	32.84	60.00	50.00	-22.88	-17.16
6	26.48047	9.70	25.30	22.04	35.00	31.74	60.00	50.00	-25.00	-18.26

**REMARKS:** The emission levels of other frequencies were very low against the limit.





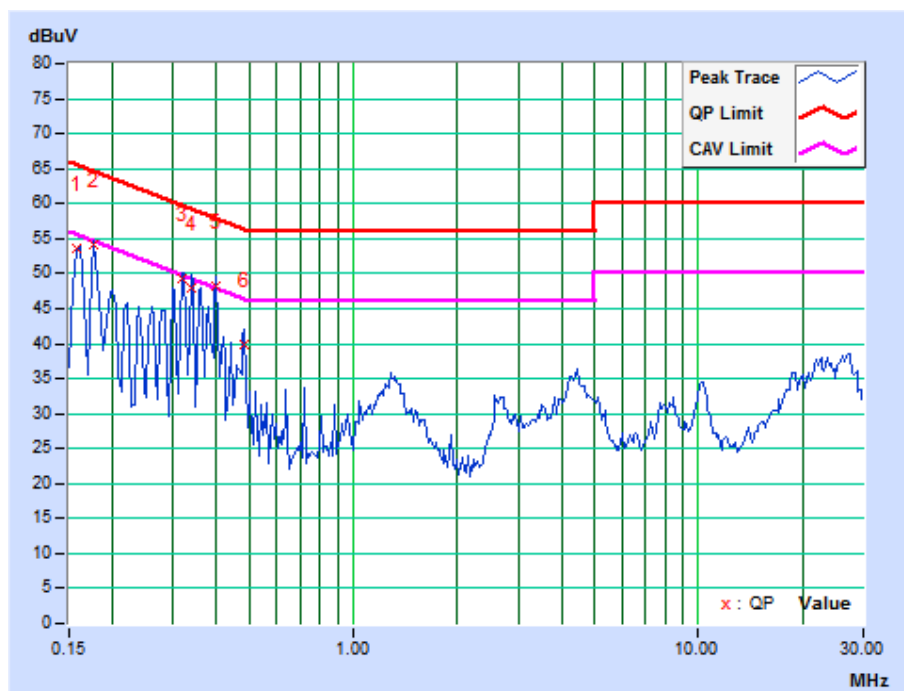
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**Test Report No.: CE191010N002**

TEST MODE	Full load and Grid	6dB BANDWIDTH	9 kHz
TEST VOLTAGE	Input DC 340V, output AC 230V 50Hz	PHASE	Line (L)
ENVIRONMENTAL CONDITIONS	23 deg. C, 54% RH	TESTED BY: Walker	
TEST MODEL	Hiverter Si-3K-H2		

No	Freq. [MHz]	Corr. Factor (dB)	Reading Value		Emission Level		Limit		Margin	
			[dB (uV)]		[dB (uV)]		[dB (uV)]		(dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15781	4.06	49.44	43.70	53.50	47.76	65.58	55.58	-12.08	-7.82
2	0.17734	6.08	48.10	38.72	54.18	44.80	64.61	54.61	-10.43	-9.81
3	0.31797	8.63	40.79	39.13	49.42	47.76	59.76	49.76	-10.34	-2.00
4	0.33750	8.64	39.30	33.34	47.94	41.98	59.26	49.26	-11.32	-7.28
<b>5</b>	<b>0.40000</b>	<b>8.72</b>	<b>39.50</b>	<b>38.46</b>	<b>48.22</b>	<b>47.18</b>	<b>57.85</b>	<b>47.85</b>	<b>-9.63</b>	<b>-0.67</b>
6	0.48203	8.66	31.21	30.23	39.87	38.89	56.30	46.30	-16.43	-7.41

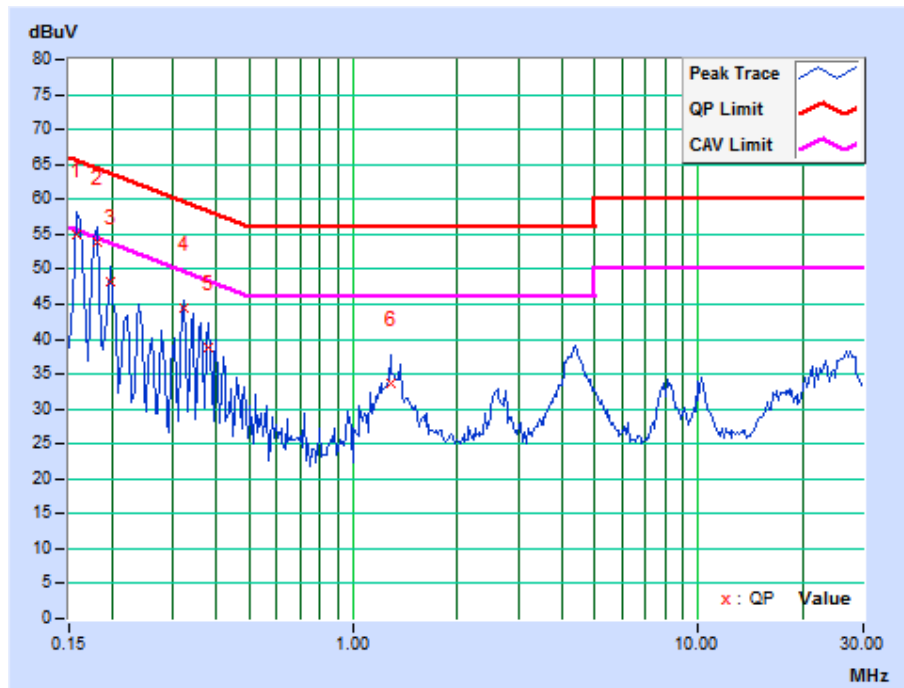
**REMARKS:** The emission levels of other frequencies were very low against the limit.



TEST MODE	Full load and Grid	6dB BANDWIDTH	9 kHz
TEST VOLTAGE	Input DC 340V, output AC 230V 50Hz	PHASE	Neutral (N)
ENVIRONMENTAL CONDITIONS	23 deg. C, 54% RH	TESTED BY: Walker	
TEST MODEL	Hiverter Si-3K-H2		

No	Freq. [MHz]	Corr. Factor (dB)	Reading Value		Emission Level		Limit		Margin	
			[dB (uV)]		[dB (uV)]		[dB (uV)]		(dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15781	4.07	50.83	46.28	54.9	50.35	65.58	55.58	-10.68	-5.23
2	0.18125	6.48	47.47	37.97	53.95	44.45	64.43	54.43	-10.47	-9.97
3	0.19687	8.10	40.11	30.52	48.21	38.62	63.74	53.74	-15.53	-15.12
4	0.32188	8.60	35.82	32.19	44.42	40.79	59.66	49.66	-15.24	-8.87
5	0.38047	8.67	30.11	23.60	38.78	32.27	58.27	48.27	-19.49	-16.00
6	1.27734	9.03	24.70	19.73	33.73	28.76	56.00	46.00	-22.27	-17.24

**REMARKS:** The emission levels of other frequencies were very low against the limit.





## 3.2 RADIATED EMISSION MEASUREMENT

### 3.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT

**TEST STANDARD: EN 61000-6-3**

**FREQUENCY RANGE OF RADIATED MEASUREMENT  
(For unintentional radiators)**

Highest frequency generated or Upper frequency of measurement used in the device or on which the device operates or tunes (MHz)	Range (MHz)
Below 108	1000
108 – 500	2000
500 – 1000	5000
Above 1000	Up to 5 times of the highest frequency or 6 GHz, whichever is less

#### FOR FREQUENCY BELOW 1000 MHz

FREQUENCY (MHz)	3m	10m
	Quasi-Peak (dBuV/m)	Quasi-Peak (dBuV/m)
30 – 230	40	30
230 – 1000	47	37

#### FOR FREQUENCY ABOVE 1000 MHz

FREQUENCY (GHz)	3m	
	PEAK(dBuV/m)	AVERAGE(dBuV/m)
1 to 3	70	50
3 to 6	74	54

**NOTE:** (1) The lower limit shall apply at the transition frequencies.  
(2) Emission level (dBuV/m) = 20 log Emission level (uV/m).

### 3.2.2 TEST INSTRUMENTS

#### FOR FREQUENCY BELOW 1GHz

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EMI Test Receiver	Rohde&Schwarz	ESU26	100005	Jun. 05,17	Jun. 04,18
EMI Test Receiver	Rohde&Schwarz	ESCI	101418	Feb. 27,17	Feb. 26,18
Trilog-Broadband Antenna	SCHWARZBECK	VULB 9168	9168-555	Nov. 10, 17	Nov. 09, 18
Trilog-Broadband Antenna	SCHWARZBECK	VULB 9168	9168-554	Dec. 17, 16	Dec. 16, 17
Preamplifier	EMCI	EMC1135	980378	Mar. 20,17	Mar. 19,18
Preamplifier	EMCI	EMC1135	980423	Mar. 20,17	Mar. 19,18
10m Semi-anechoic Chamber	CHANGLING	21.4m*12.1m*8.8m	NSEMC006	Mar. 06,17	Mar. 05,18
Test Software	ADT	ADT_Radiated_V8.7.07	N/A	N/A	N/A

- NOTES:** 1. The test was performed in 10m Chamber.  
2. The calibration interval of the above test instruments is 12 months. And the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.

#### FREQUENCY RANGE ABOVE 1GHz

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Horn Antenna	ETS-Lindgren	3117	00085519	Dec. 30, 15	Dec. 29, 17
Horn Antenna	SCHWARZBECK	BBHA 9170	BBHA9170242	Mar. 15,17	Mar. 14,18
Signal and Spectrum Analyzer	Rohde&Schwarz	FSV40	101003	Apr. 05,17	Apr. 04,18
Broadband Preamplifier	SCHWARZBECK	BBV9718	266	Mar. 21,17	Mar. 20,18
Pre-Amplifier (100MHz-26.5GHz)	EMCI	EMC 012645	980077	May 19,17	May 18,18
Pre-Amplifier (18GHz-40GHz)	EMCI	EMC 184045	980102	Nov. 08,17	Nov. 07,18
Test Software	ADT	ADT_Radiated_V8.7.07	N/A	N/A	N/A

- NOTES:** 1. The test was performed in 10m Chamber.  
2. The calibration interval of the above test instruments are 12 or 24 months. And the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.

### 3.2.3 TEST PROCEDURE

#### <Frequency Range below 1GHz>

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10 meter chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the turn table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1 GHz.

#### NOTE:

1. The resolution bandwidth of test receiver/spectrum analyzer is 120kHz for Quasi-peak detection (QP) at frequency below 1GHz.
2.  $\text{Emission level(dBuV/m)} = \text{Raw Value(dBuV)} + \text{Correction Factor(dB/m)}$
3.  $\text{Correction Factor(dB/m)} = \text{Antenna Factor (dB/m)} + \text{Cable Factor (dB)}$  (if the raw value not contains the amplifier);
4.  $\text{Correction Factor(dB/m)} = \text{Antenna Factor (dB/m)} + \text{Cable Factor (dB)} - \text{Amplifier Gain(dB)}$  (if the raw value contains the amplifier).
5.  $\text{Margin value} = \text{Emission level} - \text{Limit value}$ .

### <Frequency Range above 1GHz>

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10 meter Semi-anechoic chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna can be varied from one meter-to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement. The bore sight should be used during the test above 1GHz.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test receiver/spectrum was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.

#### NOTE:

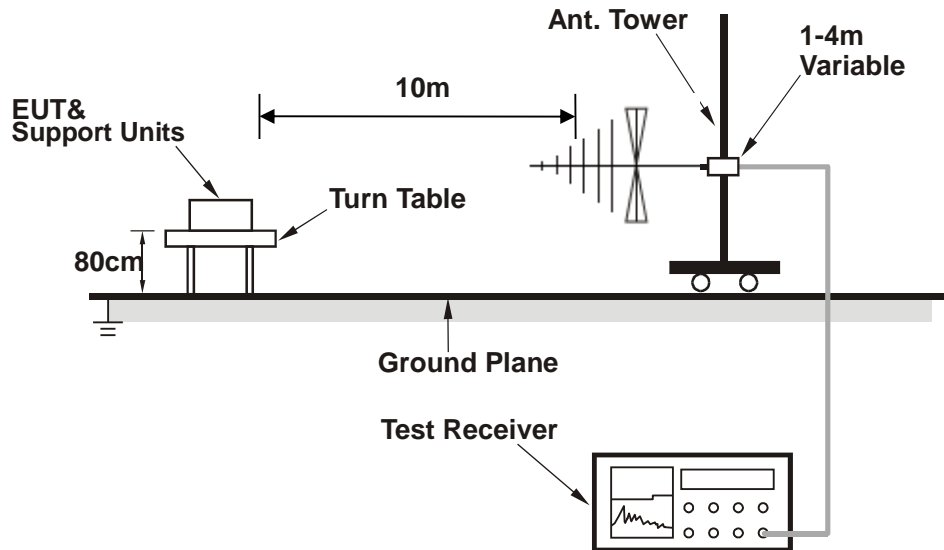
1. The resolution bandwidth is 1MHz and video bandwidth of test receiver/spectrum analyzer is 3MHz for Peak detection at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.
2. For measurement of frequency above 1000 MHz, the EUT was set 3 meters away from the receiver antenna.
3.  $\text{Emission level(dBuV/m)} = \text{Raw Value(dBuV)} + \text{Correction Factor(dB/m)}$
4.  $\text{Correction Factor (dB/m)} = \text{Antenna Factor (dB/m)} + \text{Cable Factor (dB)}$  (if the raw value not contains the amplifier).
5.  $\text{Correction Factor (dB/m)} = \text{Antenna Factor (dB/m)} + \text{Cable Factor (dB)} - \text{Amplifier Gain (dB)}$  (if the raw value contains the amplifier).
6.  $\text{Margin value} = \text{Emission level} - \text{Limit value}$ .

## 3.2.4 DEVIATION FROM TEST STANDARD

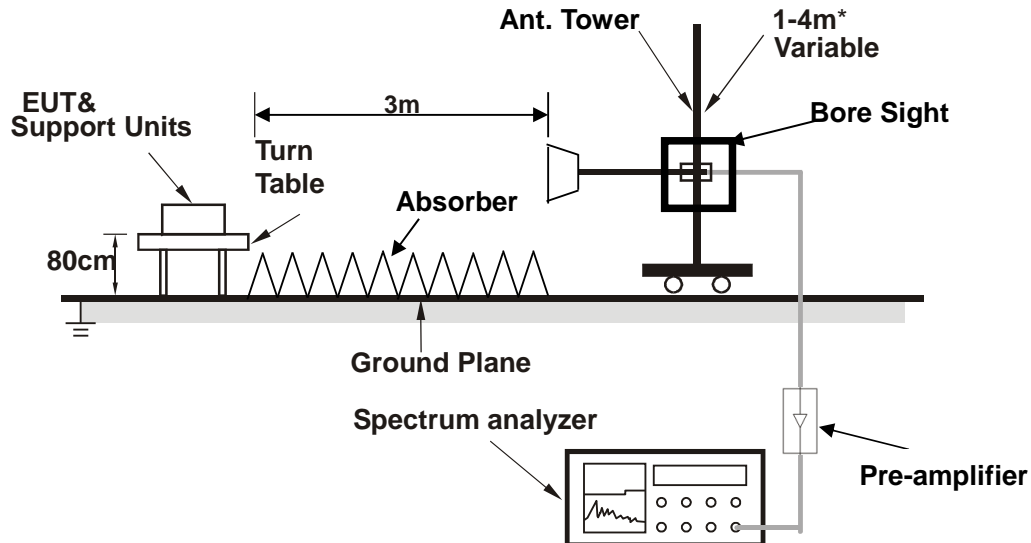
No deviation

### 3.2.5 TEST SETUP

<Frequency Range below 1GHz>



<Frequency Range above 1GHz>



\* :depends on the EUT height and the antenna 3dB beamwidth both, refer to section 7.3 of CISPR 16-2-3.

### 3.2.6 EUT OPERATING CONDITIONS

Same as item 3.1.6

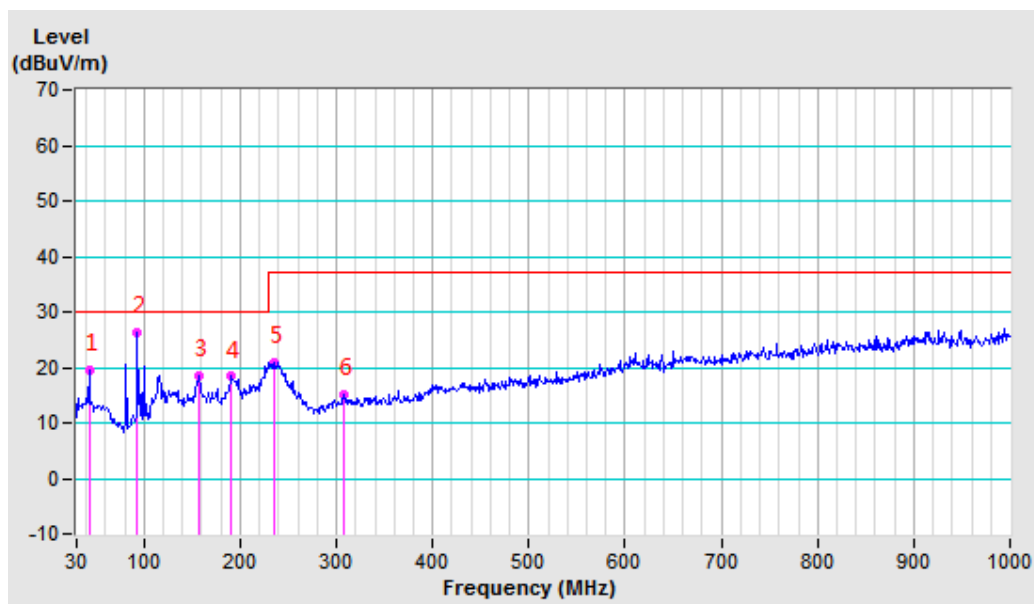


### 3.2.7 TEST RESULTS

TEST MODE	Full load and Grid	FREQUENCY RANGE	30-1000 MHz
TEST VOLTAGE	Input DC 300V, output AC 230V 50Hz	DETECTOR FUNCTION & BANDWIDTH	Quasi-Peak, 120kHz
ENVIRONMENTAL CONDITIONS	23 deg. C, 62% RH	TESTED BY: Wang	
TEST MODEL	Hiverter Si-6K-H2		

ANTENNA POLARITY & TEST DISTANCE: HORIZONTAL AT 10 M								
No.	Freq. (MHz)	Correction Factor (dB/m)	Raw Value (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)
1	42.8525	-17.55	37.12	19.57	30.00	-10.43	400	188
2	93.2925	-21.22	47.57	26.35	30.00	-3.65	200	43
3	158.0400	-16.58	35.07	18.49	30.00	-11.51	400	218
4	190.4137	-19.12	37.48	18.36	30.00	-11.64	400	40
5	236.2463	-17.69	38.62	20.93	37.00	-16.07	400	53
6	308.0263	-15.37	30.40	15.03	37.00	-21.97	400	287

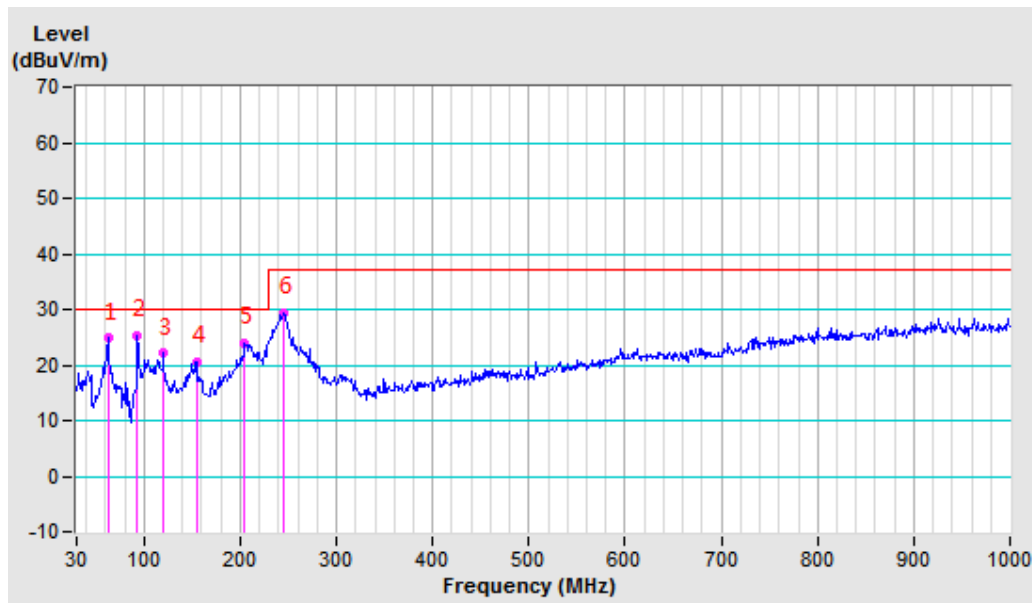
- REMARKS:** 1. Peak detector quick scan is showed on the graph and final quasi-peak detector data is measured corresponding to relevant limit and recorded in the data table.  
2. Negative sign (-) in the margin column signify levels below the limit.  
3. Frequency range scanned: 30MHz to 1000MHz.  
4. Only emissions significantly above equipment noise floor are reported



TEST MODE	Full load and Grid	FREQUENCY RANGE	30-1000 MHz
TEST VOLTAGE	Input DC 300V, output AC 230V 50Hz	DETECTOR FUNCTION & BANDWIDTH	Quasi-Peak, 120kHz
ENVIRONMENTAL CONDITIONS	23 deg. C, 62% RH	TESTED BY: Wang	
TEST MODEL	Hiverter Si-6K-H2		

ANTENNA POLARITY & TEST DISTANCE: VERTICAL AT 10 M								
No.	Freq. (MHz)	Correction Factor (dB/m)	Raw Value (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)
1	62.9800	-19.26	44.06	24.80	30.00	-5.20	100	317
2	92.8075	-21.22	46.39	25.17	30.00	-4.83	100	357
3	119.9675	-18.41	40.50	22.09	30.00	-7.91	100	187
4	154.4025	-15.76	36.28	20.52	30.00	-9.48	100	142
5	204.7212	-19.88	43.77	23.89	30.00	-6.11	100	156
6	244.9762	-16.04	45.33	29.29	37.00	-7.71	100	130

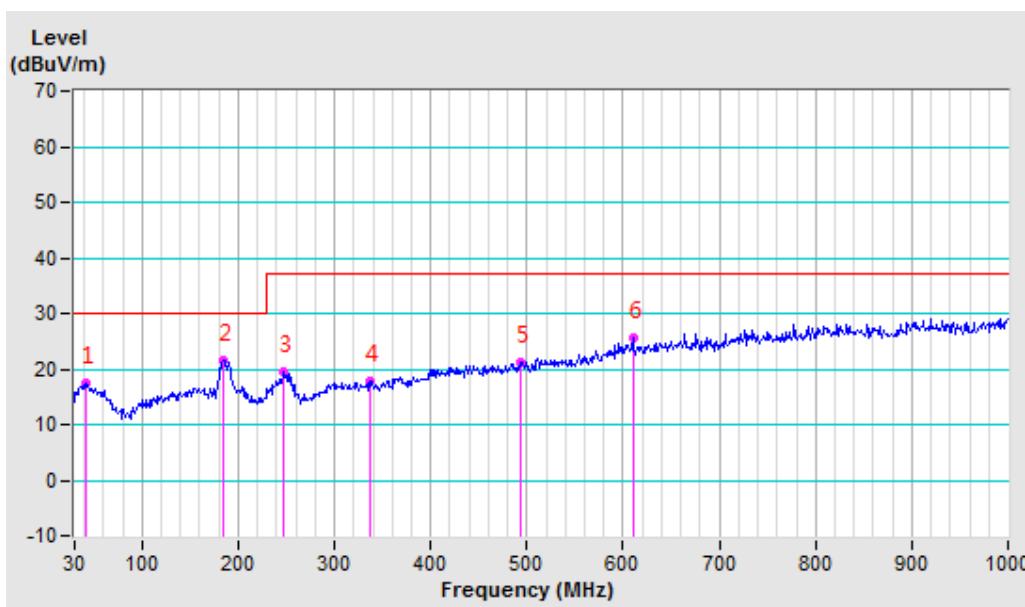
- REMARKS:** 1. Peak detector quick scan is showed on the graph and final quasi-peak detector data is measured corresponding to relevant limit and recorded in the data table.  
2. Negative sign (-) in the margin column signify levels below the limit.  
3. Frequency range scanned: 30MHz to 1000MHz.  
4. Only emissions significantly above equipment noise floor are reported



TEST MODE	Full load and Grid	FREQUENCY RANGE	30-1000 MHz
TEST VOLTAGE	Input DC 340V, output AC 230V 50Hz	DETECTOR FUNCTION & BANDWIDTH	Quasi-Peak, 120kHz
ENVIRONMENTAL CONDITIONS	23 deg. C, 62% RH	TESTED BY: Wang	
TEST MODEL	Hiverter Si-3K-H2		

<b>ANTENNA POLARITY &amp; TEST DISTANCE: HORIZONTAL AT 10 M</b>								
No.	Freq. (MHz)	Correction Factor (dB/m)	Raw Value (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)
1	40.9125	-8.84	26.37	17.53	30.00	-12.47	200	32
2	184.9575	-10.58	32.25	21.67	30.00	-8.33	400	115
3	248.0075	-9.06	28.63	19.57	37.00	-17.43	400	145
4	336.2775	-6.43	24.35	17.92	37.00	-19.08	200	316
5	492.5688	-3.98	25.13	21.15	37.00	-15.85	200	43
6	610.0600	-0.69	26.37	25.68	37.00	-11.32	400	9

- REMARKS:** 1. Peak detector quick scan is showed on the graph and final quasi-peak detector data is measured corresponding to relevant limit and recorded in the data table.  
2. Negative sign (-) in the margin column signify levels below the limit.  
3. Frequency range scanned: 30MHz to 1000MHz.  
4. Only emissions significantly above equipment noise floor are reported

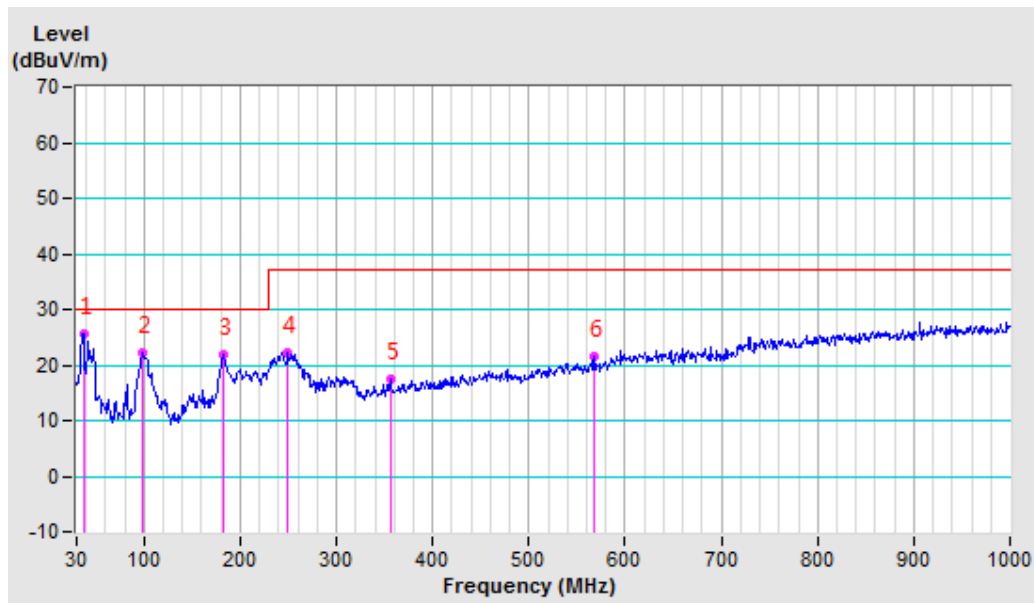




TEST MODE	Full load and Grid	FREQUENCY RANGE	30-1000 MHz
TEST VOLTAGE	Input DC 340V, output AC 230V 50Hz	DETECTOR FUNCTION & BANDWIDTH	Quasi-Peak, 120kHz
ENVIRONMENTAL CONDITIONS	23 deg. C, 62% RH	TESTED BY: Wang	
TEST MODEL	Hiverter Si-3K-H2		

<b>ANTENNA POLARITY &amp; TEST DISTANCE: VERTICAL AT 10 M</b>								
No.	Freq. (MHz)	Correction Factor (dB/m)	Raw Value (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (cm)	Table Angle (Degree)
1	37.0329	-17.16	42.83	25.67	30.00	-4.33	100	357
2	99.0190	-19.84	41.97	22.13	30.00	-7.87	300	1
3	182.6856	-18.17	40.18	22.01	30.00	-7.99	100	220
4	249.3280	-16.09	38.44	22.35	37.00	-14.65	100	357
5	356.1788	-13.02	30.44	17.42	37.00	-19.58	300	132
6	567.2129	-8.36	29.97	21.61	37.00	-15.39	100	30

- REMARKS:**
1. Peak detector quick scan is showed on the graph and final quasi-peak detector data is measured corresponding to relevant limit and recorded in the data table.
  2. Negative sign (-) in the margin column signify levels below the limit.
  3. Frequency range scanned: 30MHz to 1000MHz.
  4. Only emissions significantly above equipment noise floor are reported



### 3.3 HARMONICS CURRENT MEASUREMENT

#### 3.3.1 TEST INSTRUMENTS

TEST STANDARD: EN 61000-3-2 and EN 61000-3-12

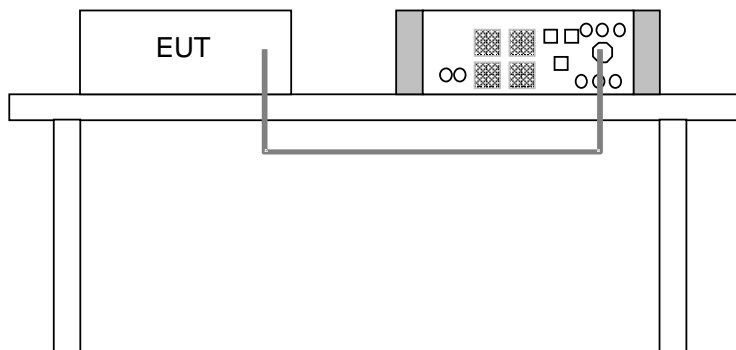
DESCRIPTION & MANUFACTURER	MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED DATE	CALIBRATED UNTIL
PRECISION POWER ANALYZER	YOKOGAWA	WT3000	91M210852	Mar. 10,17	Mar. 11,18
Test Software	YOKOGAWA	IEC61000	N/A	N/A	N/A
REFERENCE IMPEDANCE NETWORK	Voltech	EUR	3018	Apr. 08,17	Apr. 09,18

- NOTE:** 1. The test was performed in PV Room.  
 2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA and NIM/CHINA.

### 3.3.2 DEVIATION FROM TEST STANDARD

No deviation

### 3.3.3 TEST SETUP



### 3.3.4 EUT OPERATING CONDITIONS

Same as item 3.1.6

### 3.3.5 TEST RESULTS

#### FOR MODEL Hiverter Si-6K-H2

Regulation : IEC61000-3-12  
IEC61000-4-7 Ed2.0 A1  
MeasureTime : 151sec  
Model : YOKOGAWA WT3000  
Wiring : single-phase 2-wire  
Element : 1  
Range : 300V/30A  
Rating Voltage : 230 V  
I<sub>eq</sub> : 15.0000 A  
Z Impedance : 0.1200 ohm  
I<sub>1</sub> : 25.2019 A  
Power Rsce : 127.778  
Max Rsce : 33.000

#### PASS

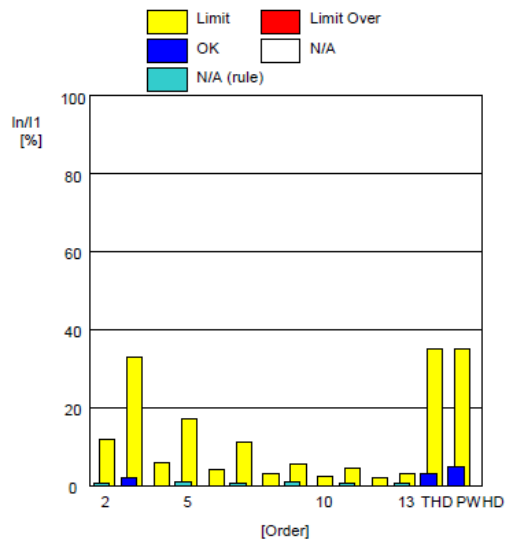
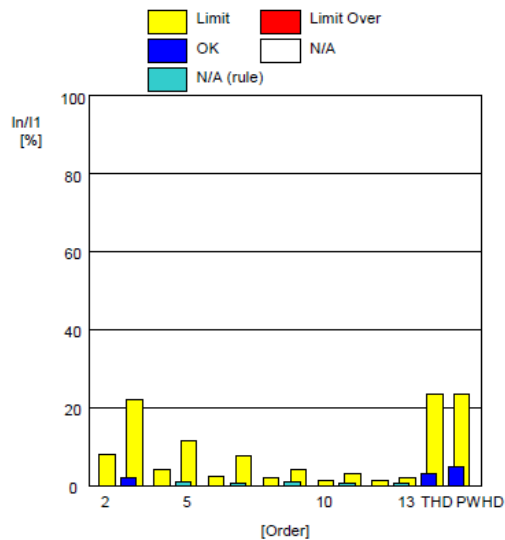
Ssc : 341550.00  
Min Rsce : 33.0000  
Apply Limit : equipment other than balanced 3-phase.  
Situation1 : 2.13% (Pass)  
Term a : 230.34 - 238.49deg (Fail)  
Term c(I5) : 0.78% (Pass)  
Term c(I7) : 0.65% (Pass)

[Average]  
Voltage(rms) : 238.26 V  
Current(rms) : 25.21 A  
Frequency : 50.00 Hz  
Power Factor : 1.00  
Sigma W : 6003.27 W  
THC : 0.74 A  
V THD : 0.77 %  
A THD : 2.95 %  
P THD : 0.01 %

[Maximum]  
Voltage(rms) : 238.34 V  
Current(rms) : 25.23 A  
Frequency : 50.08 Hz  
Power Factor : 1.00  
Sigma W : 6009.51 W  
THC : 0.75 A  
V THD : 0.80 %  
A THD : 3.04 %  
P THD : 0.01 %

Order	Measure[%]	Limit[%]	Margin[%]
2	0.2298	8.0000	97.1
3	2.1071	21.9800	90.4
4	0.1534	4.0000	96.2
5	0.7564	11.3200	93.3
6	0.1638	2.6667	93.9
7	0.6385	7.3250	91.3
8	0.1636	2.0000	91.8
9	0.8998	3.8250	76.5
10	0.1259	1.6000	92.1
11	0.7168	3.1600	77.3
12	0.0812	1.3333	93.9
13	0.6511	2.0600	68.4
THD	2.9467	23.4750	87.4
PWHD	5.0004	23.4750	78.7

Order	Measure[%]	Limit[%]	Margin[%]
2	0.2654	12.0000	97.8
3	2.1311	32.9700	93.5
4	0.1822	6.0000	97.0
5	0.7816	16.9800	95.4
6	0.1930	4.0000	95.2
7	0.6510	10.9875	94.1
8	0.1905	3.0000	93.6
9	0.9169	5.7375	84.0
10	0.1678	2.4000	93.0
11	0.7319	4.7400	84.6
12	0.1105	2.0000	94.5
13	0.6629	3.0900	78.5
THD	3.0089	35.2125	91.5
PWHD	5.1847	35.2125	85.3





BUREAU  
VERITAS

Test Report No.: CE191010N002

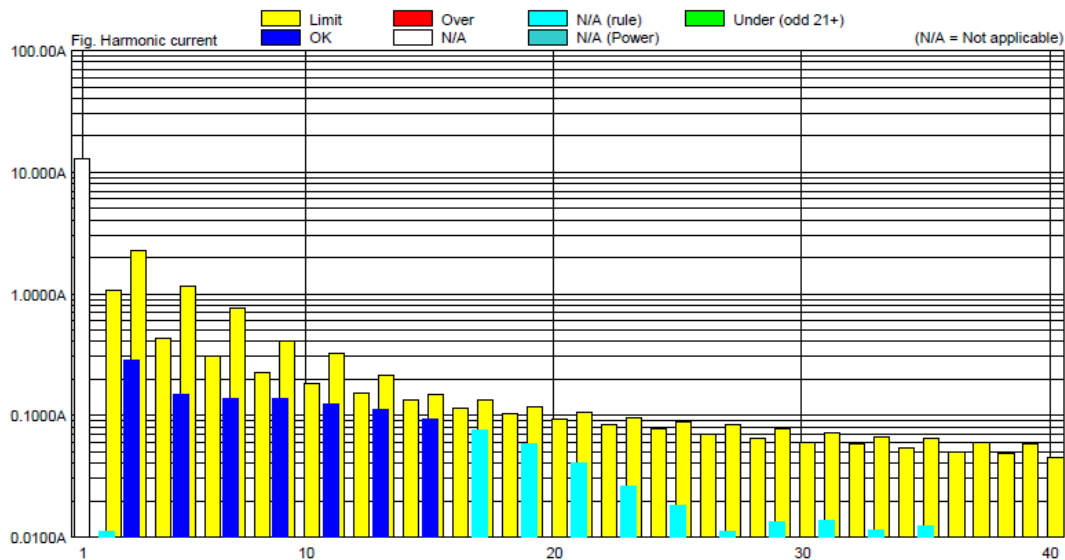
## FOR MODEL Hiverter Si-3K-H2

Regulation : IEC61000-3-2 Ed3.0 am2  
IEC61000-4-7 Ed2.0 A1  
Class : CLASS A  
MeasureTime : 150.80sec  
Model : YOKOGAWA WT3000  
Rating Voltage : 230.00 V  
Wiring : single-phase 2-wire  
Element : 1  
Range : 300V/30A  
Current(rms) : 13.0133 A  
Voltage(rms) : 230.85 V  
Frequency : 50.000 Hz  
Power Factor : 0.9994  
POHC Limit : 0.2514 A  
POHC Max : 0.0614 A  
THC : 0.4384 A

PASS

Set Fundamental I : -----  
Set Power Factor : -----  
Set P : -----  
Sigma W Max : 3004.417 W  
Sigma PF : 0.9994  
Distortion factor(V) : 0.05 %  
V THDS : 0.05 %  
V THDG : 0.05 %  
Distortion factor(A) : 3.37 %  
A THDS : 3.37 %  
A THDG : 3.37 %  
P THD : 0.00 %  
Power Limit : 75 W

Order	Measure[A]	Limit[A]	Margin[%]	Order	Measure[A]	Limit[A]	Margin[%]
1	13.0059			2	0.0113	1.0800	99.0
3	0.2855	2.3000	87.6	4	0.0064	0.4300	98.5
5	0.1482	1.1400	87.0	6	0.0056	0.3000	98.1
7	0.1362	0.7700	82.3	8	0.0072	0.2300	96.9
9	0.1405	0.4000	64.9	10	0.0060	0.1840	96.7
11	0.1256	0.3300	61.9	12	0.0052	0.1533	96.6
13	0.1127	0.2100	46.4	14	0.0069	0.1314	94.8
15	0.0943	0.1500	37.1	16	0.0041	0.1150	96.5
17	0.0743	0.1324	43.9	18	0.0039	0.1022	96.2
19	0.0581	0.1184	50.9	20	0.0047	0.0920	94.9
21	0.0407	0.1071	62.0	22	0.0040	0.0836	95.3
23	0.0264	0.0978	73.0	24	0.0037	0.0767	95.2
25	0.0182	0.0900	79.7	26	0.0027	0.0708	96.1
27	0.0112	0.0833	86.5	28	0.0024	0.0657	96.4
29	0.0135	0.0776	82.6	30	0.0022	0.0613	96.4
31	0.0139	0.0726	80.8	32	0.0020	0.0575	96.4
33	0.0116	0.0682	83.0	34	0.0023	0.0541	95.8
35	0.0126	0.0643	80.4	36	0.0026	0.0511	95.0
37	0.0096	0.0608	84.2	38	0.0031	0.0484	93.6
39	0.0099	0.0577	82.8	40	0.0021	0.0460	95.4

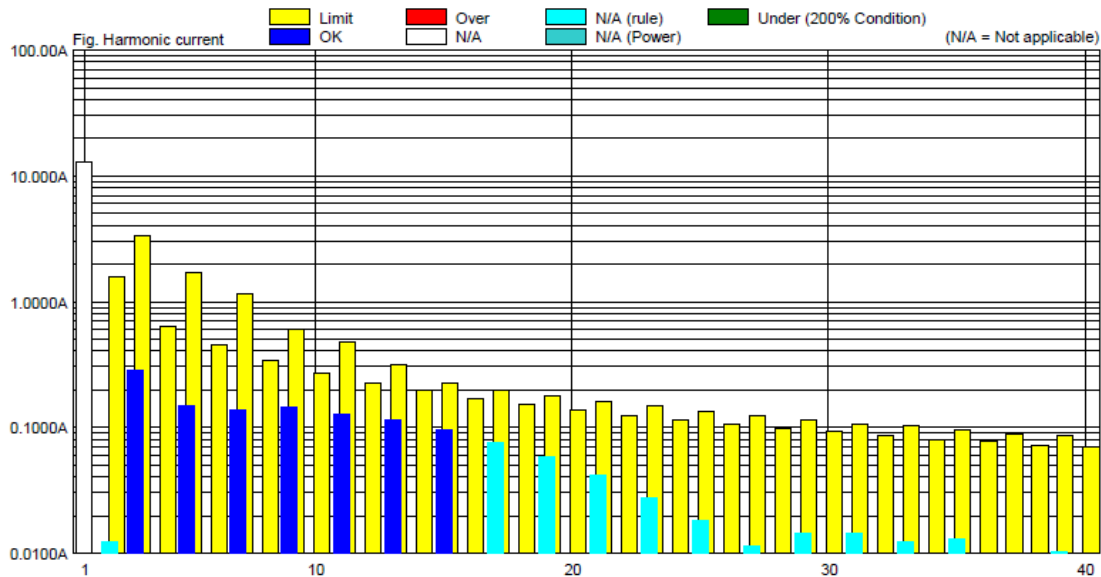


Regulation : IEC61000-3-2 Ed3.0 am2  
 IEC61000-4-7 Ed2.0 A1  
 Class : CLASS A  
 MeasureTime : 150.80sec  
 Model : YOKOGAWA WT3000  
 Rating Voltage : 230.00 V  
 Wiring : single-phase 2-wire  
 Element : 1  
 Range : 300V/30A  
 Current(rms) : 13.0233 A  
 Voltage(rms) : 230.87 V  
 Frequency : 50.004 Hz  
 Power Factor : 0.9994  
 Beyond Limit Time : 15.0800 s  
 Beyond Total Time : 0.0000 s  
 THC : 0.4419 A

**PASS**

Set Fundamental I : -----  
 Set Power Factor : -----  
 Set P : -----  
 Sigma W Max : 3004.417 W  
 Sigma PF : 0.9994  
 Distortion factor(V) : 0.05 %  
 V THDS : 0.05 %  
 V THDG : 0.05 %  
 Distortion factor(A) : 3.42 %  
 A THDS : 3.42 %  
 A THDG : 3.43 %  
 P THD : 0.00 %  
 Power Limit : 75 W

Order	Measure[A]	Limit[A]	Margin[%]	Order	Measure[A]	Limit[A]	Margin[%]
1	13.0160			2	0.0126	1.6200	99.2
3	0.2877	3.4500	91.7	4	0.0073	0.6450	98.9
5	0.1512	1.7100	91.2	6	0.0065	0.4500	98.6
7	0.1382	1.1550	88.0	8	0.0081	0.3450	97.6
9	0.1423	0.6000	76.3	10	0.0070	0.2760	97.5
11	0.1269	0.4950	74.4	12	0.0058	0.2300	97.5
13	0.1140	0.3150	63.8	14	0.0077	0.1971	96.1
15	0.0950	0.2250	57.8	16	0.0046	0.1725	97.3
17	0.0751	0.1985	62.2	18	0.0045	0.1533	97.1
19	0.0589	0.1776	66.8	20	0.0056	0.1380	95.9
21	0.0414	0.1607	74.2	22	0.0045	0.1255	96.4
23	0.0271	0.1467	81.5	24	0.0043	0.1150	96.3
25	0.0186	0.1350	86.2	26	0.0031	0.1062	97.1
27	0.0117	0.1250	90.6	28	0.0027	0.0986	97.3
29	0.0143	0.1164	87.7	30	0.0025	0.0920	97.3
31	0.0144	0.1089	86.8	32	0.0023	0.0862	97.3
33	0.0123	0.1023	88.0	34	0.0026	0.0812	96.8
35	0.0130	0.0964	86.5	36	0.0029	0.0767	96.2
37	0.0100	0.0912	89.1	38	0.0034	0.0726	95.3
39	0.0104	0.0865	88.0	40	0.0024	0.0690	96.5



### 3.4 VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

TEST STANDARD: EN 61000-3-3 and EN 61000-3-11

#### 3.4.1 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED DATE	CALIBRATED UNTIL
PRECISION POWER ANALYZER	YOKOGAWA	WT3000	91M210852	Mar. 07, 2017	Mar. 06, 2018
Test Software	YOKOGAWA	IEC61000	N/A	N/A	N/A
REFERENCE IMPEDANCE NETWORK	Voltech	EUR	3018	N/A	N/A

**NOTE:** 1. The test was performed in PV Room.  
2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA and NIM/CHINA

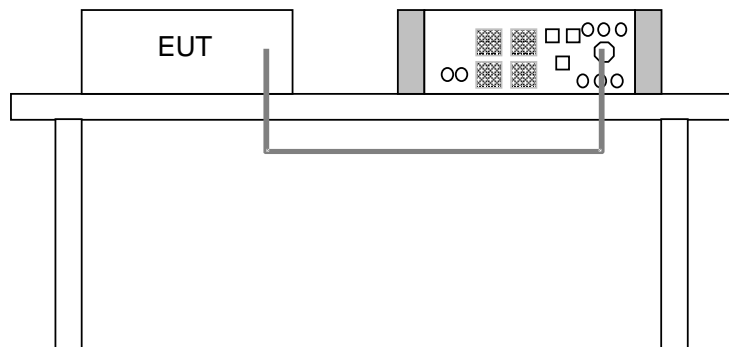
#### 3.4.2 TEST PROCEDURE

- The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under Normal Operating conditions.
- During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 120 minutes

#### 3.4.3 DEVIATION FROM TEST STANDARD

No deviation

#### 3.4.4 TEST SETUP



#### 3.4.5 EUT OPERATING CONDITIONS

Same as item 3.1.6



### 3.4.6 TEST RESULTS

#### FOR MODEL Hiverter Si-6K-H2

Regulation : IEC61000-3-11 Ed1.0  
IEC61000-4-15 Ed1.1  
Interval : 10Min0Sec  
Model : YOKOGAWA WT3000  
Wiring : single-phase 2wire  
Voltage Range : 300.00V  
Voltage U1 : 238.50V  
Set Frequency : 50Hz  
Frequency U1 : 49.995Hz  
Element : 1  
dmin : 0.10%

**PASS**

Compatibility Condition : Compliance with IEC61000-3-3  
Element1 : Pass  
dc (3.30%) : Pass  
dmax (4.00%) : Pass  
d(t) (500ms) : Pass  
Pst (1.00) : Pass  
Plt (0.65) : Pass

No.	dc[%]	dmax[%]	d(t)[ms]	Pst
1	0.06	0.20	0.00	0.24
2	0.10	0.28	0.00	0.25
3	0.08	0.26	0.00	0.25
4	0.03	0.21	0.00	0.25
5	0.04	0.21	0.00	0.25
6	0.04	0.22	0.00	0.25
7	0.02	0.21	0.00	0.25
8	0.62	0.90	0.00	0.33
9	0.02	0.32	0.00	0.27
10	0.14	0.39	0.00	0.25
11	0.03	0.21	0.00	0.25
12	0.02	0.21	0.00	0.25

Pst  
0.26

#### FOR MODEL Hiverter Si-3K-H2

Regulation : IEC61000-3-3 Ed2.0  
IEC61000-4-15 Ed1.1  
Interval : 10Min0Sec  
Model : YOKOGAWA WT3000  
Wiring : single-phase 2wire  
Voltage Range : 300.00V  
Voltage U1 : 236.51V  
Set Frequency : 50Hz  
Frequency U1 : 50.000Hz  
Element : 1  
dmin : 0.10%

**PASS**(Under dmin)

Element1 : Pass(Under dmin)  
dc (3.30%) : Pass  
dmax (4.00%) : Pass  
d(t) (500ms) : Pass  
Pst (1.00) : Pass  
Plt (0.65) : Pass

No.	dc[%]	dmax[%]	d(t)[ms]	Pst
1	0.00	0.00	0.00	0.07
2	0.00	0.00	0.00	0.07
3	0.00	0.00	0.00	0.07
4	0.00	0.00	0.00	0.07
5	0.00	0.00	0.00	0.07
6	0.00	0.00	0.00	0.07
7	0.00	0.00	0.00	0.07
8	0.00	0.00	0.00	0.07
9	0.00	0.00	0.00	0.07
10	0.00	0.00	0.00	0.07
11	0.00	0.00	0.00	0.07
12	0.00	0.00	0.00	0.07

Pst  
0.07



## 4 IMMUNITY TEST

### 4.1 GENERAL DESCRIPTION

#### 4.1.1 GENERAL DESCRIPTION OF EN 61000-6-2

<b>Product Standard:</b>	<b>EN 61000-6-2:2005</b>	
<b>Basic Standard, specification requirement, and Performance Criteria:</b>	IEC 61000-4-2	Electrostatic Discharge – ESD: 4kV Contact discharge, 8kV air discharge, Performance Criterion B
	IEC 61000-4-3	Radio-Frequency Electromagnetic Field Susceptibility Test – RS: 80-1000 MHz, 10V/m, 80% AM (1kHz), 1400-2000 MHz, 3V/m, 80% AM (1kHz) 2000-2700 MHz, 1V/m, 80% AM (1kHz) Performance Criterion A
	IEC 61000-4-4	Electrical Fast Transient/Burst - EFT AC Power line: 2kV, DC Power line: 2kV Signal line: 1kV Performance Criterion B
	IEC 61000-4-5	Surge Immunity Test: 1.2/50 us Open Circuit Voltage, 8 /20 us Short Circuit Current, AC Power Line: line to line 1 kV, line to earth 2kV DC Power Line: line to line 0.5kV line to earth 0.5kV Signal line: 1kV Performance Criterion B
	IEC 61000-4-6	Conducted Radio Frequency Disturbances Test – CS: 0.15-80 MHz, 10Vrms, 80% AM, 1kHz, Performance Criterion A
	IEC 61000-4-8	Power Frequency Magnetic Field Test, 50 Hz, 30A/m, Performance Criterion A

#### 4.1.2 PERFORMANCE CRITERIA

According to Clause 4 of EN 61000-6-2:2005 standard, the following describes the general performance criteria.

<b>CRITERION A</b>	The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation and what the user may reasonably expect from the apparatus if used as intended.
<b>CRITERION B</b>	The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. No change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation and what the user may reasonably expect from the apparatus if used as intended.
<b>CRITERION C</b>	Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

#### 4.1.3 EUT OPERATING CONDITION

Same as item 3.1.6

## 4.2 ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)

### 4.2.1 TEST SPECIFICATION

<b>Basic Standard:</b>	IEC 61000-4-2
<b>Discharge Impedance:</b>	330 ohm / 150 pF
<b>Discharge Voltage:</b>	Air Discharge: 8 kV (Direct) Contact Discharge: 4 kV (Indirect)
<b>Polarity:</b>	Positive & Negative
<b>Number of Discharge:</b>	20 times at each test point
<b>Discharge Mode:</b>	Single Discharge
<b>Discharge Period:</b>	1 second

### 4.2.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
ESD Generator	TESEQ	NSG 437	279	Mar. 07,17	Mar. 06,18
Test Software	TESEQ	V03.03	N/A	N/A	N/A
ESD Generator	EM TEST	Dito	V1211112265	Feb. 25,17	Feb. 24,18
Test Software	EM TEST	V 2.31	N/A	N/A	N/A

- NOTE:** 1. The test was performed in ESD Room.  
2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.

### 4.2.3 TEST PROCEDURE

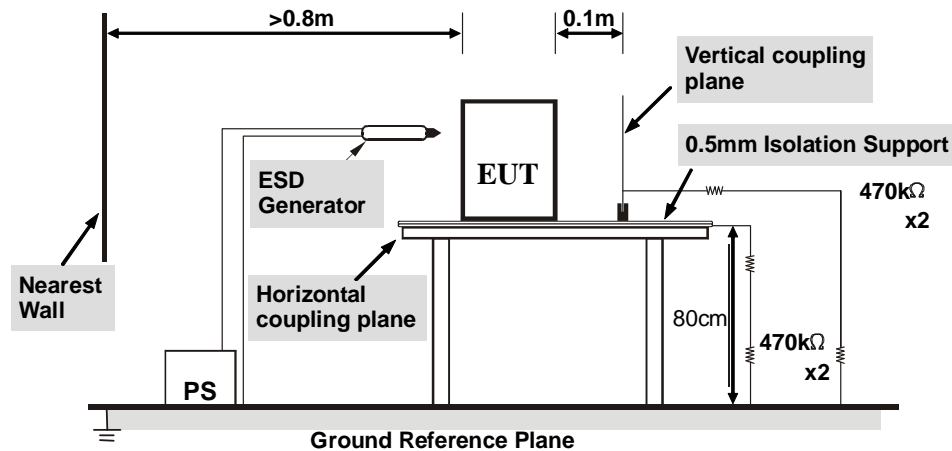
The basic test procedure was in accordance with IEC 61000-4-2:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The discharge return cable of the generator shall be kept at a distance of at least 0.2 m from the EUT whilst the discharge is being applied and should not be held by the operator.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the **Horizontal Coupling Plane** at points on each side of the EUT. The ESD generator was positioned horizontal at a distance of 0.1 meters from the EUT with the discharge electrode touching the **HCP**.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the **Vertical Coupling Plane** in sufficiently different positions that the four faces of the EUT were completely illuminated. The **VCP** (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

### 4.2.4 DEVIATION FROM TEST STANDARD

No Deviation

#### 4.2.5 TEST SETUP



**NOTE:**

### TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the **Ground Reference Plane**. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A **Horizontal Coupling Plane** (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with 940k $\Omega$  total impedance. The equipment under test, was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 0.8-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

### FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

## 4.2.6 TEST RESULTS

<b>TEST MODE</b>	See items 2.2	<b>TEST VOLTAGE</b>	See items 2.2
<b>ENVIRONMENTAL CONDITIONS</b>	24.1deg. C, 46.5% RH 101.5kPa	<b>TESTED BY:</b> Star	

Direct Discharge Application				
Test Level (kV)	Polarity	Test Point	Test Result of Contact Discharge	Test Result of Air Discharge
4	+/-	All Metal Part	A	N/A
8	+/-	All Non-metal Part	N/A	A

Indirect Discharge Application				
Discharge Level (kV)	Polarity	Test Point	Test Result of HCP	Test Result of VCP
4	+/-	HCP	A	N/A
4	+/-	VCP	N/A	A

**NOTE:** A: There was no change compared with initial operation during the test.

## 4.3 RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD IMMUNITY TEST (RS)

### 4.3.1 TEST SPECIFICATION

<b>Basic Standard:</b>	IEC 61000-4-3
<b>Frequency Range:</b>	80-1000MHz, 1400-2000MHz, 2000-2700MHz
<b>Field Strength:</b>	10V/m
<b>Modulation:</b>	1kHz Sine Wave, 80%, AM Modulation
<b>Frequency Step:</b>	1 % of fundamental
<b>Polarity of Antenna:</b>	Horizontal and Vertical
<b>Antenna Height:</b>	1.5m
<b>Dwell Time:</b>	at least 3 seconds

### 4.3.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Signal Generator	Agilent	N5181A	MY50142530	Oct. 13,16	Oct. 12,17
Bilog Antenna	Teseq	CBL 6111D	27089	July 19,17	Jul. 18,18
Antenna Log-Periodic	AR	ATR80M6G	0337307	N/A	N/A
Antenna Log-Periodic	AR	ATS700M11G	0336821	N/A	N/A
Switch Controller	AR	SC1000	0337343	N/A	N/A
RF Power Meter	ESE	4242	13984	Nov. 04,16	Nov. 03,17
Power Sensor	ESE	51011EMC	35716	Nov. 04,16	Nov. 03,17
Power Sensor	ESE	51011EMC	35715	Nov. 04,16	Nov. 03,17
E-Field probe	Narda	NBM-520	2403/01B	Mar. 08,17	Mar. 07,18
Power Amplifier	TESEQ	CBA 1G-150	T44029	N/A	N/A
Power Amplifier	TESEQ	CBA 3G-100	T44030	N/A	N/A
Power Amplifier	TESEQ	CBA 6G-050	1041204	N/A	N/A
Dual Directional Coupler	TESEQ	C5982	95208	Nov. 04,16	Nov. 03,17
Dual Directional Coupler	TESEQ	C6187	95175	Nov. 04,16	Nov. 03,17
Dual Directional Coupler	TESEQ	CPH-274F	M251304-01	Nov. 04,16	Nov. 03,17
Test Software	ADT	BVADT_RS_V 7.6.4-DG	N/A	N/A	N/A

- NOTE:** 1. The test was performed in RS chamber.  
2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.

### 4.3.3 TEST PROCEDURE

The test procedure was in accordance with IEC 61000-4-3

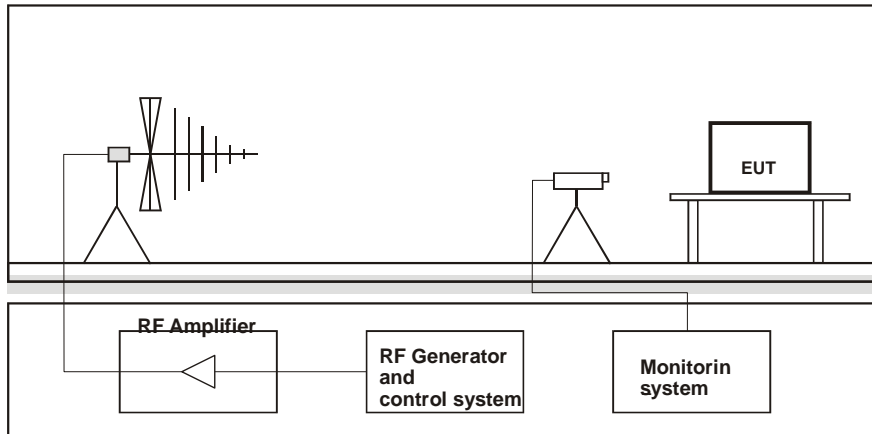
- a. The testing was performed in a fully-anechoic chamber.
- b. The frequency range is swept from 80 MHz to 1000 MHz, 1400MHz to 2000MHz, 2000MHz to 2700MHz with the signal 80% amplitude modulated with a 1kHz sine wave.
- c. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised and to respond, but shall in no case be less than 0,5s.
- d. The field strength levels were 10V/m.
- e. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

### 4.3.4 DEVIATION FROM TEST STANDARD

No Deviation



### 4.3.5 TEST SETUP



#### NOTE:

##### TABLETOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

##### FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

#### 4.3.6 TEST RESULTS

<b>TEST MODE</b>	See items 2.2	<b>TEST VOLTAGE</b>	See items 2.2
<b>ENVIRONMENTAL CONDITIONS</b>	27.1deg. C, 51.2% RH	<b>TESTED BY:</b> Star	

Field Strength (V/m)	Test Frequency Note#1 (MHz)	Polarization of antenna (Horizontal / Vertical)	Test Distance (m)	Test Result	Remark
10	80 - 1000	H&V	3	A	N/A
3	1400 - 2000	H&V	3	A	N/A
1	2000 - 2700	H&V	3	A	N/A

Note#1:

Tested Israel SII Frequencies 89,100,107,144,163,196,244,315,434,460,600,825,845,880 MHz

**NOTE:** A: There was no change compared with initial operation during the test.

## 4.4 ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST (EFT)

### 4.4.1 TEST SPECIFICATION

<b>Basic Standard:</b>	IEC 61000-4-4
<b>Test Voltage:</b>	Power Line: 2kV
<b>Polarity:</b>	Positive & Negative
<b>Impulse Frequency:</b>	5 kHz
<b>Impulse Waveshape :</b>	5/50 ns
<b>Burst Duration:</b>	15 ms
<b>Burst Period:</b>	300 ms
<b>Test Duration:</b>	1 min.

### 4.4.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Combination wave Module	TESEQ	CDN 3061	1361	May 19,17	May 18,18
Telecom Surge Module	TESEQ	NSG 3060 Mainframe	1404	May 19,17	May 18,18
Automated 3- Phase Coupling/ Decoupling Network	TESEQ	CDN 3063	2131	May 19,17	May 18,18
CDN	TESEQ	CDN HSS-2	34275	Jun. 21,17	Jun. 20,18
CDN	TESEQ	CDN 118	30741	Jun. 21,17	Jun. 20,18
Test Software	TESEQ	CDM 3061_0002.30	1361	N/A	N/A
Test Software	TESEQ	HVM 3060_0002.30	293	N/A	N/A

**NOTE:** 1. The test was performed in EMS Room.

2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.

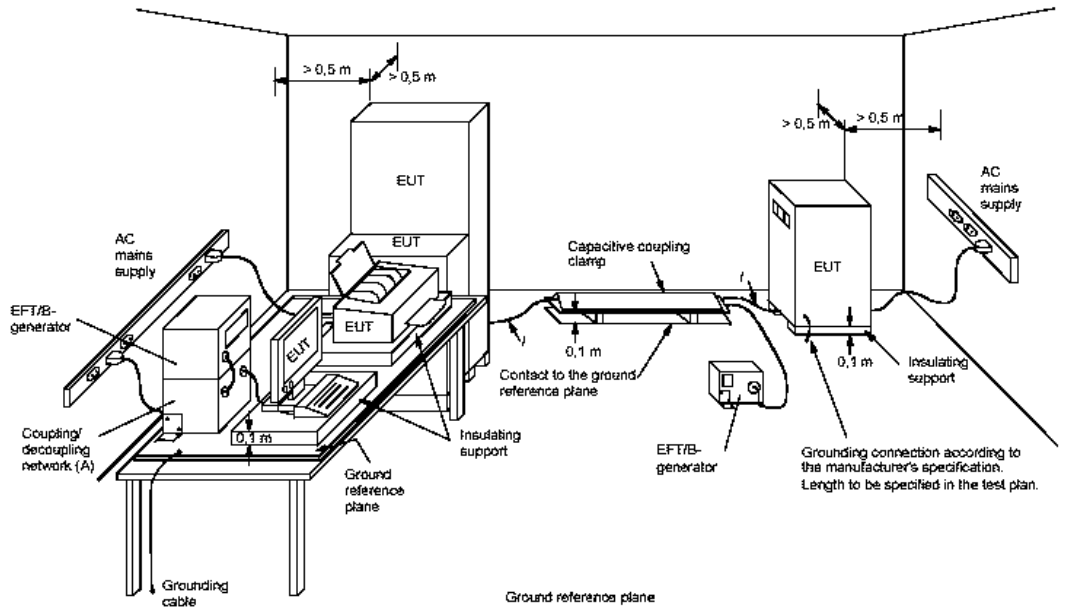
### 4.4.3 TEST PROCEDURE

- Both positive and negative polarity discharges were applied.
- The length of the "hot wire" from the coaxial output of the EFT generator to the terminals on the EUT should not exceed 0.5 meter  $\pm$  0.05 meter.
- The duration time of each test sequential was 1 minute.
- The transient/burst waveform was in accordance with IEC 61000-4-4, 5/50ns.

### 4.4.4 DEVIATION FROM TEST STANDARD

No deviation.

## 4.4.5 TEST SETUP



### NOTE:

#### TABLETOP EQUIPMENT

The configuration consisted of a wooden table standing on the Ground Reference Plane and should be located 0.1m +/- 0.01m above the Ground Reference Plane.

The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system. A minimum distance of 0.5m was provided between the EUT and the walls of the laboratory or any other metallic structure.

#### FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-4 and its cables, were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system.

## 4.4.6 TEST RESULTS

<b>TEST MODE</b>	See items 2.2	<b>TEST VOLTAGE</b>	See items 2.2
<b>ENVIRONMENTAL CONDITIONS</b>	26.6 deg. C, 47.9% RH	<b>TESTED BY:</b> Walker	

<b>Pulse Voltage</b>	<b>2.0 kV</b>		<b>kV</b>		<b>kV</b>		<b>kV</b>	
<b>Pulse Polarity</b>	<b>+</b>	<b>—</b>	<b>+</b>	<b>—</b>	<b>+</b>	<b>—</b>	<b>+</b>	<b>—</b>
L	A	A	/	/	/	/	/	/
N	A	A	/	/	/	/	/	/
PE	A	A	/	/	/	/	/	/
L+N	A	A	/	/	/	/	/	/
L+PE	A	A	/	/	/	/	/	/
N+PE	A	A	/	/	/	/	/	/
L+N+PE	A	A	/	/	/	/	/	/
DC Line	A	A	/	/	/	/	/	/

**NOTE:** A: There was no change compared with initial operation during the test.

## 4.5 SURGE IMMUNITY TEST

### 4.5.1 TEST SPECIFICATION

<b>Basic Standard:</b>	IEC 61000-4-5
<b>Wave-Shape:</b>	Combination Wave 1.2/50 us Open Circuit Voltage 8 /20 us Short Circuit Current
<b>Test Voltage:</b>	AC Power Line :Line to Line: 1kV Line to PE: 2kV
<b>Surge Input/Output:</b>	L-N, L-PE, N-PE
<b>Generator Source</b>	2 ohm between networks
<b>Impedance:</b>	12 ohm between network and ground
<b>Polarity:</b>	Positive/Negative
<b>Phase Angle:</b>	0° /90°/180°/270°
<b>Pulse Repetition Rate:</b>	1 time / 60 sec.
<b>Number of Tests:</b>	5 positive and 5 negative at selected points

### 4.5.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Combination wave Module	TESEQ	CDN 3061	1361	May 19,17	May 18,18
Telecom Surge Module	TESEQ	NSG 3060 Mainframe	1404	May 19,17	May 18,18
Automated 3- Phase Coupling/ Decoupling Network	TESEQ	CDN 3063	2131	May 19,17	May 18,18
CDN	TESEQ	CDN HSS-2	34275	Jun. 21,17	Jun. 20,18
CDN	TESEQ	CDN 118	30741	Jun. 21,17	Jun. 20,18
Test Software	TESEQ	CDM 3061_0002.30	1361	N/A	N/A
Test Software	TESEQ	HVM 3060_0002.30	293	N/A	N/A

- NOTE:** 1. The test was performed in EMS Room.  
2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.

### 4.5.3 TEST PROCEDURE

a. For EUT power supply:

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT:

The surge is applied to the lines via the capacitive coupling. The coupling / decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

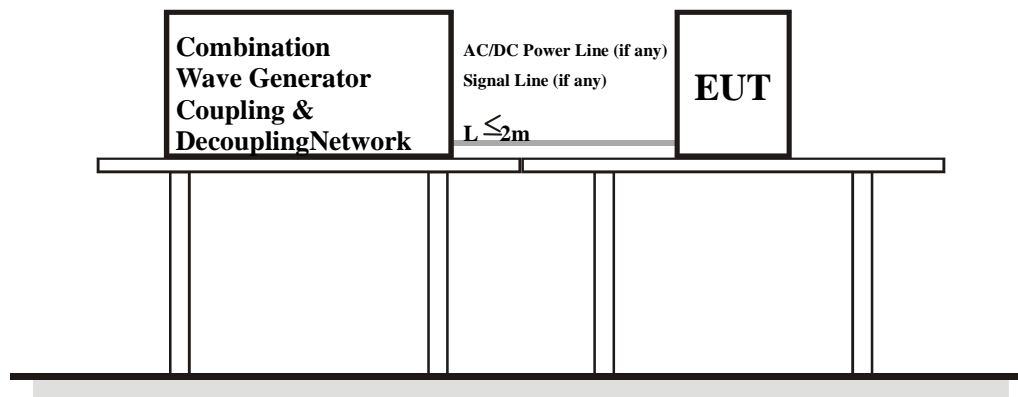
c. For test applied to unshielded symmetrically operated interconnection / telecommunication lines of EUT:

The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

### 4.5.4 DEVIATION FROM TEST STANDARD

No deviation.

### 4.5.5 TEST SETUP





## 4.5.6 TEST RESULTS

TEST MODE	See items 2.2	TEST VOLTAGE	See items 2.2
ENVIRONMENTAL CONDITIONS	25.5deg. C, 51.2% RH	TESTED BY: Walker	

### AC/DC Power port:

\Phase angle \ Test result \Voltage (kV) \ Test point\ Polarity		0°	90°	180°	270°	DC Power Port
1.0	L-N	+	B	B	B	N/A
		—	B	B	B	N/A
2.0	L-PE	+	B	B	B	N/A
		—	B	B	B	N/A
2.0	N-PE	+	B	B	B	N/A
		—	B	B	B	N/A
0.5	DC Line	+	N/A	N/A	N/A	A
		—	N/A	N/A	N/A	A

**NOTE:** A: There was no change compared with initial operation during the test.

B: The EUT would malfunction and recover by itself.



## 4.6 IMMUNITY TO CONDUCTED DISTURBANCES INDUCED BY RF FIELDS (CS)

### 4.6.1 TEST SPECIFICATION

<b>Basic Standard:</b>	IEC 61000-4-6
<b>Frequency Range:</b>	0.15 MHz - 80 MHz
<b>Field Strength:</b>	10V <sub>r.m.s</sub>
<b>Modulation:</b>	1kHz Sine Wave, 80%, AM Modulation
<b>Frequency Step:</b>	1 % of fundamental
<b>Coupled Cable:</b>	Power Mains & DC Power Line
<b>Coupling Device:</b>	CDN-M3 (3 wires) & Clamp

### 4.6.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Signal Generator	Rohde&Schwarz	SME06	829498/006	Oct. 13,16	Oct. 12,17
CDN	Luthi	L-801M2/M3	2015	Sep.21,16	Sep. 20,17
CDN(AUX)	TESEQ	CDN M016	27452	Nov. 18,16	Nov. 17,17
CDN	TESEQ	T200A	26944	Apr. 05,17	Apr. 04,18
CDN	TESEQ	T400A	26536	Apr. 05,17	Apr. 04,18
CDN	TESEQ	ST08A	32256	Apr. 05,17	Apr. 04,18
6dB 50Watt Attenuator	HUBER+SUHNER	5906.17.0005	303688	Oct. 13,16	Oct. 12,17
Power Amplifier	PRANA	DR 220	1512-1788	NA	NA
Electromagnetic Injection Clamp	Luthi	EM101	35640	Sep.22,16	Sep. 21,17
C/S Test System	HAEFELY	WinPAMP	NSEMC002	N/A	N/A
Test Software	ADT	BVADT_CS_V 7.6.2	N/A	N/A	N/A

- NOTE:** 1. The test was performed in CS test room.  
 2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.

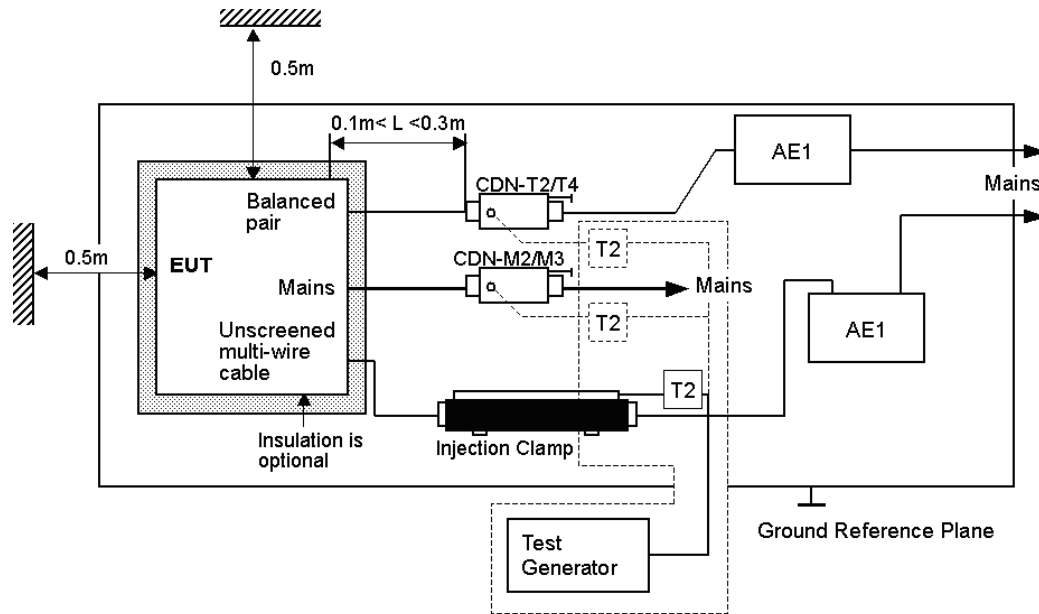
#### 4.6.3 TEST PROCEDURE

- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50-ohm load resistor.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- e. The dwell time of the amplitude modulated carrier at each frequency shall not be less than the time necessary for the EUT to be exercised and to respond, but shall in no case be less than 0,5 s. The sensitive frequencies (e.g. clock frequencies) shall be analyzed separately.
- f. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.

#### 4.6.4 DEVIATION FROM TEST STANDARD

No deviation.

## 4.6.5 TEST SETUP



NOTE: The EUT clearance from any metallic obstacles shall be at least 0.5m.

All non-excited input ports of the CDNs shall be terminated by  $50\Omega$  loads.

### NOTE:

#### FLOOR-STANDING EQUIPMENT

The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

## 4.6.6 TEST RESULTS

<b>TEST MODE</b>	See items 2.2	<b>TEST VOLTAGE</b>	See items 2.2
<b>ENVIRONMENTAL CONDITIONS</b>	24.6deg. C, 49.3% RH	<b>TESTED BY:</b> Star	

Voltage (V)	Test Frequency Note <sup>#1</sup> (MHz)	Tested Line	Injection Method.	Test Result	Remark
10	0.15 – 80	AC Line	CDN-M3	A	N/A
10	0.15 – 80	DC Line	Clamp	A	N/A

Note<sup>#1</sup>: Tested Israel SII Frequencies 0.2,0.53,1,1.5,7.1,13.56,21,27.12,40.68,65,68 MHz

**NOTE:** A: There was no change compared with initial operation during the test.

## 4.7 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST

### 4.7.1 TEST SPECIFICATION

<b>Basic Standard:</b>	IEC 61000-4-8
<b>Frequency Range:</b>	50Hz
<b>Field Strength:</b>	30A/m
<b>Observation Time:</b>	5 minute
<b>Inductance Coil:</b>	Rectangular type, 1mx1m

### 4.7.2 TEST INSTRUMENTS

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Magnetic Field Tester	HAEFELY	MAG100.1	150579	Oct. 13,16	Oct. 12,17
Test Software	N/A	N/A	N/A	N/A	N/A

**NOTE:** 1. The test was performed in Shielding Room 843.  
2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to CEPREI/CHINA, GRGT/CHINA and NIM/CHINA.

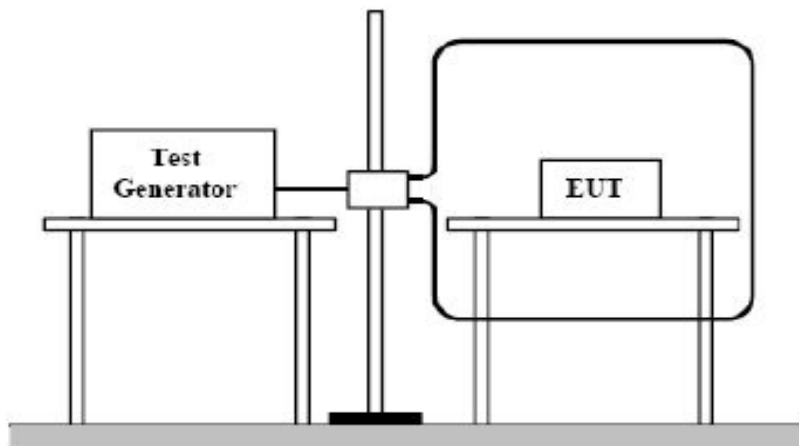
### 4.7.3 TEST PROCEDURE

- The equipment is configured and connected to satisfy its functional requirements.
- The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

### 4.7.4 DEVIATION FROM TEST STANDARD

No deviation.

## 4.7.5 TEST SETUP



### NOTE:

#### TABLETOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

#### FLOOR-STANDING EQUIPMENT

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

## 4.7.6 TEST RESULTS

<b>TEST MODE</b>	See items 2.2	<b>TEST VOLTAGE</b>	See items 2.2
<b>ENVIRONMENTAL CONDITIONS</b>	26.1 deg. C, 51.2% RH	<b>TESTED BY:</b> Walker	

Magnetic field direction	Testing result	Remark
X - Axis	A	30A/m
Y - Axis	A	30A/m
Z - Axis	A	30A/m

**NOTE:** A: There was no change compared with initial operation during the test.



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## 5 PHOTOGRAPHS OF THE TEST CONFIGURATION

Please refer to the attached file (Test Setup Photo)



## 6 APPENDIX A – MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE EUT BY THE LAB

No any modifications were made to the EUT by the lab during the test.

---END---